# CL1-MG210

**NEW** 2020



## Chromatic Confocal Controller

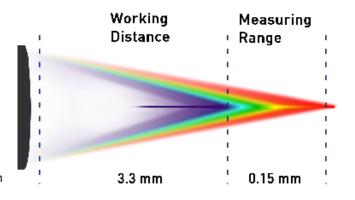


CL1-MG210 stands out for high precision roughness measurement on all materials.

It is used in many high-tech industries such as semiconductors, 3C or research laboratories.

The new CL1-MG210 offers outstanding performance:

- Universal diameter (27mm)
- Axial resolution (from nanometer to micrometer scales)
- A few hundred grams for easy OEM integration
- Reference for roughness measurements (norm ISO25178-602)
- Optimal lateral resolution (from less than 1µm)
- Maximal Numerical Aperture (>0,7)



#### All materials

**Industrial** 

Accurate measurement





PERFECT FOR





## **DESIGNED FOR**



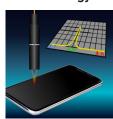
Glass



Semiconductors



Metrology



Distance



**Thickness** 



Roughness



Shape

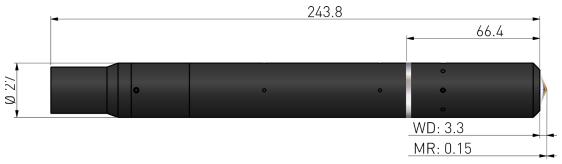




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### **DIMENSIONAL DRAWING\***



Nota: All dimensions are in mm



## SPECIFICATIONS\*

Product	Unit	CL1-MG210
Order code		03PS0112101
Measuring Range	mm	0.15
Working Distance	mm	3.3
Numerical aperture		0.71
Max. sample slope	•	± 42
Axial model		Standard
90° folded model		Option
Max. linearity error**	μm	± 0.025
Static noise**	nm	7
Axial resolution**	μm	0.042
Lateral resolution	μm	1.1
Spot size	μm	2.7
Photometric efficiency		5
Min. measurable thickness***	μm	7.5
Length Diameter Weight	mm mm g	243.8 27 268

- \*\* With CCS electronics (PRIMA & OPTIMA+)
- \*\*\* Typical value considering a layer of glass, i.e. considering a refractive index n=1.51



#### ASSOCIATED WITH

#### **OPTICAL FIBER**

## CONTROLLER



- Standard cladding
- Stainless steel cladding
- Armored fiber



- ZENITH
- PRIMA, OPTMA +
- PRIMA 2
- STIL-DUO

\*Specifications are subject to modifications